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Sub-band-gap laser micromachining of lithium niobate

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Laser processing of insulators and semiconductors is usually realized using photon energies exceeding the band-gap energy. This makes laser processing of insulators difficult since high photon energies typically require either a pulsed laser or a frequency-doubled continuous-wave laser. A new method is reported which enables us to do laser processing of lithium niobate using sub-band-gap photons. Using high scan speeds, moderate power densities, and sub-band-gap photon energies results in volume removal rates in excess of $10^6 \mu\text{m}^3/\text{s}$. This enables fast micromachining of small piezoelectric structures, or simple etching of grooves for precision positioning of optical fibers. © 1995 American Institute of Physics.

Lithium niobate is used in many different applications ranging from surface acoustic wave devices, e.g., bandpass filters, to photonic devices such as optical waveguides and holograms. A major problem in manufacturing lithium-niobate-based devices is its well-known resistivity towards standard machining techniques like wet etching or reactive ion etching.¹ As a consequence, a number of laser ablation and laser etching experiments has been reported since the mid-eighties,²⁻⁴ all utilizing photon energies above the band gap to ensure sufficient power absorption in the substrate.

Lithium niobate has a band gap of about 3.75 eV at room temperature. At present, pulsed excimer lasers (e.g., KrF at 5.00 eV) or frequency-doubled (fd) continuous-wave (cw) lasers (e.g., Ar ion at 4.82 eV) are the most powerful lasers available for laser processing above the band gap of lithium niobate. A comparison of the removal rates achievable with ablation and etching processes based on these lasers can be found in Ref. 5. The maximum etch rates quoted in Ref. 5 are $\sim 1 \mu\text{m}^3/\text{s}$ for the cw laser process and $0.05 \mu\text{m}^3/\text{pulse}$ (10 Hz) for the excimer laser process. The volumetric removal rate of the excimer laser depends on the size of the actual structure wanted.

In this letter, we show the results of a new laser processing technique using a cw Ar-ion laser in a direct-write setup. The process is mainly a reduction process utilizing a sub-band-gap photon energy of 3.53 eV, thereby enabling selective removal of the laser-processed substrate by subsequent wet etching. Combining a scan speed of 100 mm/s, a laser spot of $2\omega=8 \mu\text{m}$, and 750 mW of laser power results in corresponding volumetric removal rates in excess of $10^6 \mu\text{m}^3/\text{s}$.

The experimental setup consists of a cw Ar-ion laser with a maximum power of 2.5 W at 351 nm, UV optics, and a stainless-steel process chamber with a quartz window mounted on a dc motor stage. The powers quoted in this letter are powers at the laser, and the optical loss in our setup is $\sim 50\%$ at 351 nm. The samples investigated were commercially available 0.5 mm thick 128°-rotated Y-cut lithium niobate, and the process gas used was 5 mbar of N_2 . After laser processing, the samples were characterized by scanning electron microscopy (SEM), and secondary ion mass spectroscopy (SIMS) during all stages of cleaning and etching. More experimental details can be found in Refs. 6 and 7.

Although congruent lithium niobate has a room-temperature absorption coefficient of less than 1 cm^{-1} at 351 nm,⁸ some absorption is still possible through the participation of defect levels in the energy gap. The defect levels will mainly be due to Li and O vacancies in the crystal. Electrons excited to or from these levels will quickly relax, heating the crystal lattice in the process. Because of the low thermal conductivity of lithium niobate, heat dissipation away from the laser spot will be low. Since the band gap of lithium niobate decreases rapidly with increasing temperature⁸ and since we operate at a wavelength close to the band-gap energy, positive feedback will eventually enable band-to-band photon absorption.

The precise power and time needed to initiate the absorption process depends on the optical configuration and the

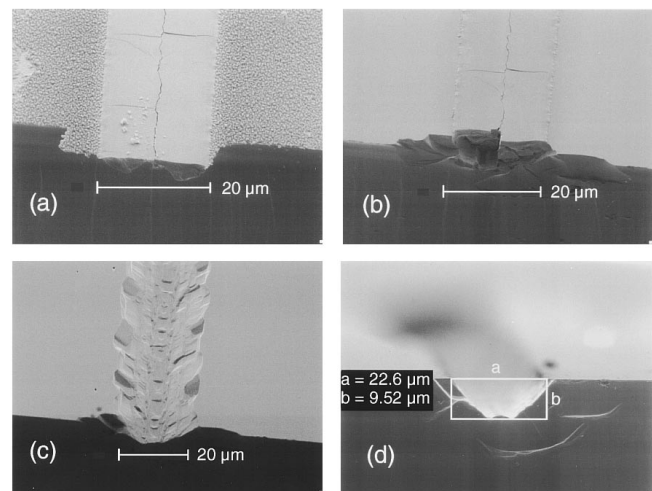


FIG. 1. LiNbO_3 sample after laser processing. 300 mW, 100 mm/s, $2\omega=8 \mu\text{m}$. (a) Before any cleaning, (b) after cleaning with ethanol, (c)(d) and after hot HF etch.

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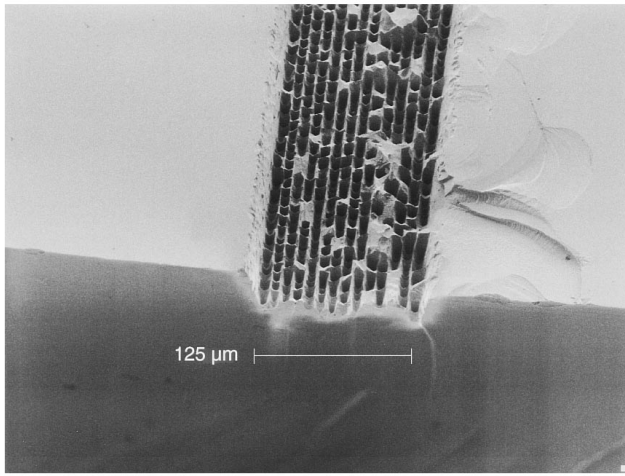


FIG. 2. Equidistant (10 μm) parallel scans. 300 mW, 1 mm/s, $2\omega=8 \mu\text{m}$.

quality of the substrate, but focusing ~ 500 mW of laser power on a $8 \mu\text{m}$ spot for a few seconds can initiate absorption. This creates a damaged area with a much higher absorption coefficient than the original substrate. Using this area as a starting point, the laser spot can be scanned across the undamaged substrate at high speeds and at lower laser powers while maintaining the process.⁶ We explain this through heat dissipation in all directions away from the laser spot including the forward direction. In this way, the absorption coefficient of the substrate is increased before the laser spot travels across. The fact that the resulting trench depth depends on the scan speed of the laser spot⁶ suggests that the time constant for the process is in the millisecond range.

The process is a combination of ablation and transformation as can be seen in Fig. 1(a), which shows a SEM micrograph of a laser-processed sample before any cleaning. The figure shows a well-defined boundary between droplets of redeposited ablated material and an area of transformed material on the substrate surface. The redeposited material can easily be removed with ethanol [Fig. 1(b)], whereas the transformed material maintains a high degree of chemical resistivity. It can, however, be removed by 50% concentrated HF at 70°C in less than 1 h, which leaves the unprocessed substrate intact as can be seen in Figs. 1(c) and 1(d). Figure 2 demonstrates that the process can be used for fast large-area removal of lithium niobate.

The samples were characterized by SIMS during all stages of cleaning and etching. Table I summarizes the count

TABLE I. SIMS element count ratios.

	Unprocessed. Pure material	No cleaning. Redeposited material	After ethanol. Transformed material	After hot HF. Remaining material
Li/Nb	1/4	4/1	1/33	1/4
O/Nb	1/6	2/3	1/20	1/5

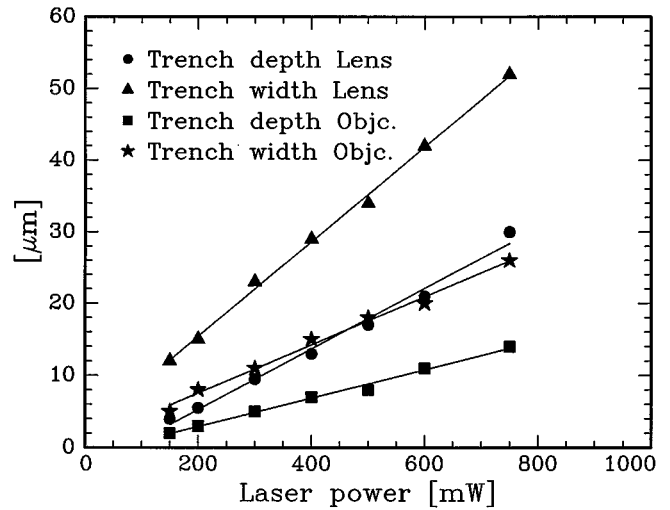


FIG. 3. Trench size vs laser power. 100 mm/s, lens: $2\omega=8 \mu\text{m}$, objc.: $2\omega=1 \mu\text{m}$.

ratios during the different stages of processing. The SIMS data show that the redeposited material is Li- and O-rich in contrast to the transformed material, which is heavily reduced in Li and O. Also notable is that the remaining substrate maintains its original composition after treatment with hot HF.

In order to demonstrate the volumetric removal rates achievable with our system, we investigated the power regime 100–750 mW for a scan speed of 100 mm/s. Results are shown in Fig. 3 for two different optical configurations,⁶ for a reflective objective with a numerical aperture of 0.5 and for a singlet lens with a focal length of 80 mm. The figure shows that the trench size scales linearly with power for both configurations. At 100 mW the process could not be maintained. Using the lens, 750 mW results in a corresponding volumetric rate of more than $10^6 \mu\text{m}^3/\text{s}$.

In conclusion, we have demonstrated a sub-band-gap laser micromachining technique for lithium niobate. Using sub-band-gap photons enables one to utilize readily available and powerful cw Ar-ion lasers, thereby achieving volumetric removal rates orders of magnitude higher than previously reported in the literature. This opens the possibility of fast micromachining of complex piezoelectric structures as well as grooves for precision positioning of optical fibers in lithium niobate.

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